Spin Injection and Relaxation in Ferrom agnet-Sem iconductor Heterostructures

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Abstract

We present a complete description of spin injection and detection in Fe/A $\frac{1}{8}$ G $\frac{1}{8}$ A s/G $\frac{1}{8}$ A s heterostructures for tem peratures from 2 to 295 K. Measurements of the steady-state spin polarization in the sem iconductor indicate three tem perature regimes for spin transport and relaxation. At tem peratures below 70 K, spin-polarized electrons injected into quantum well structures form excitons, and the spin polarization in the quantum well depends strongly on the electrical bias conditions. At intermediate temperatures, the spin polarization is determined primarily by the spin relaxation rate for free electrons in the quantum well. This process is slow relative to the excitonic spin relaxation rate at lower temperatures and is responsible for a broad maximum in the spin polarization between 100 and 200 K. The spin injection e ciency of the Fe/A $\frac{1}{8}$ G $\frac{1}{8}$ A S Schottky barrier decreases at higher temperatures, although a steady-state spin polarization of at least 6% is observed at 295 K.

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Ferrom agnetic metals such as iron are natural sources of spin-polarized electrons, and sem iconductors have been shown to be an ideal host for the transport and manipulation of spin. The demonstration of electrical spin injection from conventional ferrom agnetic metals [1, 2, 3, 4, 5] has addressed the possibility of purely electronic control of spin transport in sem iconductors. For example, the steady-state spin polarization electrically injected into a quantum well from an Fe/A l_x G $a_{1,x}$ A s Schottky contact has been shown to be as high as 32 % at 2 K [6]. Improved e ciencies have been achieved for injection through an articial tunnel barrier [7, 8], and evidence for electrical spin injection at room temperature has been reported [1, 9]. In spite of these successes, no experiment on ferrom agnet-sem iconductor heterostructures has addressed the properties of these devices over a wide range of temperatures and electrical bias conditions.

In this Letter we report on a comprehensive study of spin injection in Fe/Al $_{\rm k}$ G al $_{\rm k}$ A s/G aA sheterostructures from 2 K to 295 K.W hen a shallow G aA squantum well (QW) is used as a spin detector, three distinct temperature regimes for spin transport and relaxation are identified. Below 70 K, the bias dependence of the spin polarization in the QW is clearly in uenced by excitonic elects. A pronounced peak appears in the steady-state polarization over a narrow bias range. This peak disappears rapidly with increasing temperature. Between 70 and 150 K, the spin polarization increases with temperature over a wide range of bias voltages. We show that the temperature dependence of the polarization signal from 2 to 150 K can be understood in terms of a crossover from excitonic to free electron spin relaxation in the quantum well. Above 180 K, the steady-state spin polarization decreases in all heterostructures that we have studied but is at least 6% at 295 K.M easurements using a bulk G aAs spin detector indicate that the decrease at higher temperatures is due in part to a reduction in the spin injection electron of the Schottky barrier.

Each of the epitaxial ferrom agnet-sem iconductor heterostructures used for these measurements consists of a Schottky diode in series with a n-i-p junction [1, 2]. The design of the Schottky tunnel barrier follows the approach of Hanbicki et al. [6]. Three sam ples will be discussed in detail in this paper. The rst two, denoted I and II, use quantum wells as optical detectors. Sam ple I is grown on a p-type (p = $1 ext{ } 10^{18} ext{ cm}^3$) G aAs (100) substrate and consists of 300 nm p-G aAs (p = $1 ext{ } 10^{17} ext{ cm}^3$), 150 nm p-A $l_{0:1}$ G $a_{0:9}$ As (p = $1 ext{ } 10^{16} ext{ cm}^3$), 25 nm i-A $l_{0:1}$ G $a_{0:9}$ As, 10 nm i-G aAs QW, 25 nm i-A $l_{0:1}$ G $a_{0:9}$ As, followed by a 100 nm n-A $l_{0:1}$ G $a_{0:9}$ As (n = $1 ext{ } 10^{16} ext{ cm}^3$) drift layer. The Schottky junction is then formed by

growing an ! n^+ transition layer going from n=1 10^{16} cm 3 up to 5 10^{18} cm 3 over a thickness of 15 nm . This is followed by 15 nm n^+ A $l_{0:1}$ G $a_{0:9}$ A s ($n^+=5$ 10^{18} cm 3), 5 nm Fe, and a 2.5 nm A lcapping layer. The Fe and A llayers are grown at a temperature of 0 C. Sample II is identical to sample I except for a lower doping (p=3 10^{15} cm 3) in the p-A $l_{0:1}$ G $a_{0:9}$ A s layer im mediately beneath the QW structure. Sample III diers from sample I only in that the 10 nm i-G aAs QW is eliminated. The optical emission from this sample is dominated by G aAs band-edge luminescence emitted from the substrate. The samples are processed into light-emitting-diodes by photolithography and wet etching. A fler processing, each device is annealed at 250 C in a N_2 atmosphere for one hour. A schematic of a sample is shown in the inset of Fig. 1. Light is collected through the top of the device.

The spin detection measurements are carried out using the electrolum inescence polarization (ELP) technique in the Faraday geometry [10]. Light is emitted by electrons that tunnel into the sem iconductor from the Fe lm and recombine with unpolarized holes from the substrate. The electrolum inescence polarization $P = (I_+ I) = (I_+ + I)$, where I_+ and I are the intensities of right and left circularly polarized light, is measured as a function of magnetic eld, temperature, and the bias voltage across the device. For samples I and II, the electrolum inescence (EL) at low temperatures is dominated by the QW heavy-hole exciton, for which P is equal to the steady-state electron spin polarization in the QW. The polarization for these samples below 200 K is determined from the intensities integrated over a window 3 meV wide surrounding the heavy-hole exciton peak. At higher temperatures, the electrolum inescence from samples I and II becomes dominated by recombination in the substrate and the data are windowed over a $5\,\mathrm{m}$ eV window around the EL m axim um . The EL from sample III is due to band-edge recombination in GaAs at all temperatures, and in this case P, which is determined from the spectrum integrated over a 40 meV window, is expected to be equal to half of the steady-state spin polarization in the detection region [11]. Only the raw optical polarization P will be shown in this paper. This includes small contributions from magneto-absorption in the Fe lm (less than 2% in all cases discussed here) and, at very low temperatures, the Zeem an splitting of electron and hole states in the sem iconductor.

The electrolum inescence polarization P for sample I is shown as a function of magnetic eld in Fig. 1. The data are obtained at temperatures ranging from 2 K to 295 K at the bias voltages indicated in the legend. As demonstrated in previous work [1, 2], P is

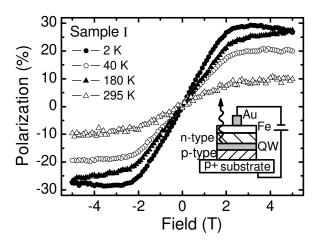


FIG. 1: Electrolum inescence polarization (ELP) as a function of magnetic eld for sample I at the temperatures and bias voltages indicate in the legend. A schematic of the structure for samples I and II is shown in the inset. The quantum well is omitted in sample III.

approximately proportional to the magnetization of iron, which saturates at an applied eld of H=4~M=2:1~T. This magnetic eld dependence is observed for all three samples. For samples I and II, a polarization of 8% at 2.5 T (6% after background subtraction) is observed even at 295 K.

A complete picture of the spin transport properties of these devices can be obtained by measuring the optical polarization as a function of the bias voltage between the ferrom agnetic electrode and the substrate. For this measurement, the magnetic eld is held xed at 2.5 T, just above the saturation eld of Fe. Results at several dierent temperatures are shown for sample II in Fig. 2. These data show three distinguishing features. The rst is the pronounced peak in the polarization as a function of bias that is observed at 2 K. Second, the maximum polarization at 180 K is higher than that measured at 40 K. Finally, there is a signicant decrease in the polarization signal between 180 and 295 K.

It is evident from Fig. 2 that the temperature and bias dependence of the polarization signal are complex. Complete maps of the polarization as a function of temperature and bias voltage are provided in Figs. 3 (a-c) for the three samples discussed in this paper. The closed symbols in Fig. 3 (d) show the polarization at the voltages along the solid curves in each of the rst three panels. The data in Fig. 3 (d) approximate the maximum polarization at each temperature.

It is clear from Fig. 3 that there are two regions of maximum polarization signal for QW

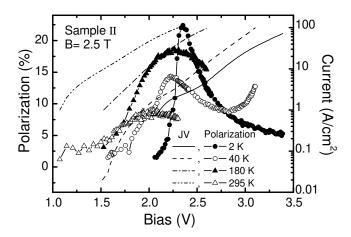


FIG. 2: The polarization (symbols) is shown as a function of the bias voltage for sample II in a eld of 2.5 T at the temperatures indicated in the legend. The curves are the corresponding current-voltage characteristics.

detectors. The rst is at low temperature over a narrow bias range. The second maximum occupies a much wider bias range at intermediate temperatures, between 70 and 200 K. For the bulk GaAs detector of sample III, there is a single maximum at low temperature, and the polarization signal decreases with increasing temperature above 20 K for all biases. The temperature dependence of the maximum polarization that we observe for QW detectors agrees qualitatively with recent results obtained below 100 K with an articulational barrier as the injector[8].

The polarization signal P measured in these experiments can be related to the injected spin by $P = S_i = (1 + r_i = s_i)$, where S_i (maximum value = 1=2) is the spin that is injected into the quantum well, r_i is the recombination time, s_i is the spin relaxation time, and is a factor determined by the optical selection rules. For the two QW samples below 200 K, the EL is dominated by the heavy-hole exciton, and $s_i = 2$. For sample III, there is no connement and $s_i = 1$ at all temperatures[11]. We focus reton the QW samples. The fact that the polarization signal always increases with bias near threshold can be related to a decrease in $s_i = 1$ with increasing bias, as would be expected due to the attening of the bands in the n-i-p junction. The sharp peak in the response at low temperature occurs at the bias where the ratio $s_i = 1$ is smallest. This peak disappears with increasing temperature because $s_i = 1$ increases, as is expected for heavy-hole excitons in shallow quantum wells[12] and veriled for our QW 's using Hanle electime easurements[11].

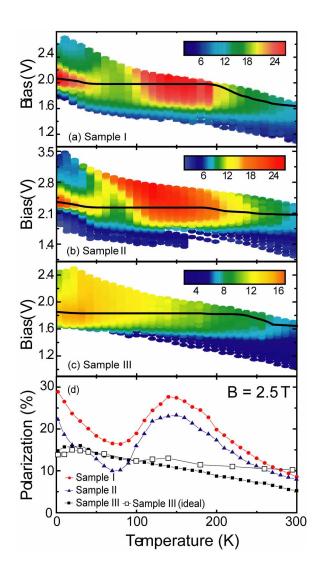


FIG. 3: (color) (a), (b), (c) The polarization measured at the electrolum inescence peak is shown as a function of the temperature and bias voltage for samples I, II, and III in a eld of 2.5 T. The color scales are indicated in each panel. (d) Optical polarization (closed symbols) is shown as a function of temperature for each of the samples in this study. The data are shown at points along the solid black curves in panels (a)-(c). The maximum polarization expected for sample III for the ideal case of 100% injection e ciency is shown using open symbols. This is based on the calibration procedure described in the text.

There are, however, important features of the QW data in Fig. 3 that cannot be due $\sin p \ln p$ to variations in the recombination $\sin e$. As can be seen in Figs. 3(a) and (b), the rapid decrease in P from 10-70 K occurs only over a narrow bias range. For higher bias voltages, the polarization signal actually increases with temperature from 10 K up to 150 K.

These unusuale ects are due to the dependence of the spin relaxation $time_s$ on bias voltage and tem perature.

The behavior between 70 and 150 K can be understood in terms of the D 'yakonov-Perel (DP) mechanism [13, 14], in which the electron spins precess incoherently about the spin-orbit eld. In a manner similar to motional narrowing, this process can be suppressed if the momentum scattering time $_{\rm p}$ is short enough. For the case of electron spin-relaxation in quantum wells, $_{\rm s}^{-1}$ / $_{\rm p}$ T [14, 15], and so we expect $_{\rm s}$ to increase with increasing temperature if the momentum scattering time decreases with temperature faster than 1=T . As noted by Jiang et al.[8], the rapid onset of optical phonon scattering above 70 K therefore provides a reasonable explanation for the increase in the polarization signal at higher temperatures. We not that P (and hence $_{\rm s}$) continues to increase up to 150 K [15].

The DP mechanism alone, however, cannot explain the tem perature and bias dependence that is observed below 70 K.W e have considered various models that treat consistently the dependence of the DP relaxation rate on tem perature and the kinetic energy of the injected carriers. Most importantly, none of the common models for free electron spin relaxation predicts the increase in P with temperature that is observed at high biases. As noted above, this trend starts at progressively lower temperatures (far below the onset of optical phonon scattering) at the highest bias voltages. C learly some other process besides the DP mechanism is contributing to the electron spin relaxation at low temperatures.

The key to understanding the low-tem perature behavior observed in Figures 2 and 3 is the form ation of excitons. The electron-hole exchange interaction has been shown to enhance the spin relaxation rate signi cantly compared to that observed for free electrons[16, 17, 18, 19, 20]. The exchange interaction can be tuned by controlling the spatial overlap of the electron and hole wave functions. For example, a factor of ve decrease in the spin relaxation rate in a GaAsQW at 20 K was observed by V inatierriet al. as the electric eld was increased from 0 to 30 kV/cm [17]. Any other parameter that decreases the electron-hole overlap, such as an increase in temperature or a decrease in the con ning potential, should also suppress the excitonic contribution to the electron spin relaxation rate.

The experimental situation is complicated by the fact that the polarization signal depends on both the recombination and spin relaxation rates. For this reason, it is extremely discult to model the full bias dependence at low temperatures. As noted above, the sharp decrease in the maximum signal with increasing T between 2 and 70 K is consistent with the observed

increase in the excitonic recombination time. However, the fact that the polarization signal increases with T at higher biases is due to a crossover from excitonic spin relaxation at low temperatures to slower free electron spin relaxation at higher temperatures. The electron-hole overlap can be suppressed either by increasing temperature or by increasing the electric eld at the quantum well. An example of the latter electron be seen in the data for Sample II at 40 K in Fig. 2. P is actually increasing at the highest biases, for which the measured Stark shift indicates an electric eld in the QW of order 10^4 V/cm . A lithough the details of the low-temperature behavior will depend on both $_{\rm S}$ and $_{\rm T}$, the clear boundary separating the low-temperature regime from the broad maximum observed at intermediate temperatures in Figs. 3(a) and (b) is associated with the suppression of the electron-hole exchange.

We therefore nd that the observed polarization signal in the quantum well system s below 150 K can be understood in terms of a crossover from an excitonic regime at low temperatures to the regime above 70 K in which free electron spin relaxation by the DP mechanism applies. Above 150 K, however, the polarization signal begins to decrease at all biases. This can be attributed in part to a crossover from QW to bulk-dominated emission, but a more fundamental question is whether the spin injection eciency, which we have assumed to be constant for the purposes of the preceding discussion, decreases with increasing temperature. Sample III, which does not have a QW, provides an opportunity to test this assumption. In this case, recombination occurs in the p-G aAs layer at all temperatures, and excitonic ects are relatively weak. The maximum ELP at low temperatures is approximately 15%, which corresponds to a steady-state spin polarization of 30%.

The advantage of using a bulk recomb ination region is that the ratio $_{\rm r}=_{\rm s}$ can be measured over the entire temperature range by means of the Hanle e ect[11], thus allowing us to calibrate the spin detector[9]. From the Hanle curve at each temperature we calculate the ideal value $P=S_i=(1+_{\rm r}=_{\rm s})$ of the optical polarization signal for the case $S_i=0.21$, which corresponds to a spin injection e ciency of 100% from Fe. The results are shown as the open symbols in Fig. 3 (d). The relative agreement with the results found for sample III at low temperatures suggests that them aximum spin injection e ciency achieved with the Schottky barrier is nearly unity. At temperatures above 100 K the measured values start to drop faster than the ideal case, falling 50% below the limiting value at room temperature. This suggests that some other mechanism, such as thermionic emission, contributes signicantly

to the injection current above 100 K.

Our results demonstrate that the spin injection e ciency of the Fe/A l_x G $a_{1\,x}$ As Schottky barrier remains extremely high up to 150 K and is of order 50% at room temperature. The bias and temperature dependence of the steady-state polarization are attributed primarily to changes in the sensitivity of the spin detector, and steady-state spin polarizations greater than 20% can be reached over a large range of temperature and bias voltage. Our discussion has ignored the possibility that the injection e ciency itself may depend on the bias conditions, as discussed in several theoretical proposals [21, 22, 23]. These approaches might explain some of the extremely strong bias dependence observed at low temperatures, but they cannot be addressed satisfactorily until a spin detector is developed that can be calibrated over a wide range of bias conditions. The experiment discussed here has identified several of the factors that must be considered in order to achieve this goal.

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